

MOSFET

Metal Oxide Semiconductor Field Effect Transistor

CoolMOS™ C7

600V CoolMOS™ C7 Power Transistor IPP60R060C7

Data Sheet

Rev. 2.0 Final



IPP60R060C7

1 Description

CoolMOS™ C7 is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies.

600V CoolMOS™ C7 series combines the experience of the leading SJ MOSFET supplier with high class innovation.

The 600V C7 is the first technology ever with R_{DS(on)}*A below 10hm*mm².

Features

- Suitable for hard and soft switching (PFC and high performance LLC)
- Increased MOSFET dv/dt ruggedness to 120V/ns
- Increased efficiency due to best in class FOM R_{DS(on)}*E_{oss} and R_{DS(on)}*Q_g
- Best in class R_{DS(on)} /package
- Qualified for industrial grade applications according to JEDEC (J-STD20 and JESD22)

Benefits

- Increased economies of scale by use in PFC and PWM topologies in the application
- Higher dv/dt limit enables faster switching leading to higher efficiency
- Enabling higher system efficiency by lower switching losses
- Increased power density solutions due to smaller packages
- Suitable for applications such as server, telecom and solar
- Higher switching frequencies possible without loss in efficiency due to low Eoss and Qg

Applications

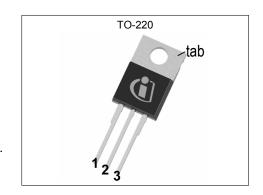
PFC stages and PWM stages (TTF, LLC) for high power/performance SMPS e.g. Computing, Server, Telecom, UPS and Solar.

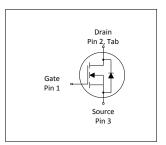
Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.



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Parameter	Value	Unit				
V _{DS} @ T _{j,max}	650	V				
R _{DS(on),max}	60	m $Ω$				
$Q_{g.typ}$	68	nC				
I _{D,pulse}	135	A				
I _{D,continuous} @ T _j <150°C	54	A				
E _{oss} @400V	8.1	μЈ				
Body diode di/dt	420	A/µs				

Type / Ordering Code	Package	Marking	Related Links
IPP60R060C7	PG-TO 220	60C7060	see Appendix A

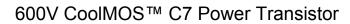














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2 Maximum ratings at $T_j = 25$ °C, unless otherwise specified

Table 2 **Maximum ratings**

Danamatan	Ob. a.l		Value	s	11!4		
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Continuous drain current ¹⁾	I _D	-	-	35 22	А	T _C =25°C T _C =100°C	
Pulsed drain current ²⁾	I _{D,pulse}	-	-	135	Α	T _C =25°C	
Avalanche energy, single pulse	E AS	-	-	159	mJ	I _D =6.4A; V _{DD} =50V; see table 10	
Avalanche energy, repetitive	E AR	-	-	0.80	mJ	I _D =6.4A; V _{DD} =50V; see table 10	
Avalanche current, single pulse	I _{AS}	-	-	6.4	Α	-	
MOSFET dv/dt ruggedness	dv/dt	-	-	120	V/ns	V _{DS} =0400V	
Gate source voltage (static)	V _{GS}	-20	-	20	V	static;	
Gate source voltage (dynamic)	V _{GS}	-30	-	30	V	AC (f>1 Hz)	
Power dissipation	P _{tot}	-	-	162	W	<i>T</i> _C =25°C	
Storage temperature	$T_{ m stg}$	-55	-	150	°C	-	
Operating junction temperature	T _j	-55	-	150	°C	-	
Mounting torque	-	-	-	60	Ncm	M3 and M3.5 screws	
Continuous diode forward current	I _S	-	-	35	Α	<i>T</i> _C =25°C	
Diode pulse current ²⁾	I _{S,pulse}	-	-	135	Α	T _C =25°C	
Reverse diode dv/dt ³⁾	dv/dt	-	-	20	V/ns	V _{DS} =0400V, I _{SD} <=9.9A, T _j =25° see table 8	
Maximum diode commutation speed	di _f /dt	-	-	420	A/μs	V_{DS} =0400V, I_{SD} <=9.9A, T_{j} =25°0 see table 8	
Insulation withstand voltage	V _{ISO}	-	-	n.a.	V	V _{rms} , T _C =25°C, t=1min	

 $^{^{1)}}$ Limited by $T_{j\,\text{max}}.$ $^{2)}$ Pulse width t_p limited by $T_{j,\text{max}}$ $^{3)}$ Identical low side and high side switch



3 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Complete	Values			1114	Nata / Tank Operation
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case	R _{thJC}	-	-	0.772	°C/W	-
Thermal resistance, junction - ambient		-	-	62	°C/W	leaded
Thermal resistance, junction - ambient for SMD version	R _{thJA}	-	-	-	°C/W	n.a.
Soldering temperature, wavesoldering only allowed at leads	T _{sold}	-	-	260	°C	1.6mm (0.063 in.) from case for 10s



4 Electrical characteristics at T_j =25°C, unless otherwise specified

Table 4 **Static characteristics**

Parameter	0		Values			
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V _{(BR)DSS}	600	-	-	V	V_{GS} =0V, I_D =1mA
Gate threshold voltage	$V_{(GS)th}$	3	3.5	4	V	$V_{\rm DS}$ = $V_{\rm GS}$, $I_{\rm D}$ =0.8mA
Zero gate voltage drain current	I _{DSS}	-	- 10	1 -	μΑ	V _{DS} =600, V _{GS} =0V, T _j =25°C V _{DS} =600, V _{GS} =0V, T _j =150°C
Gate-source leakage current	I _{GSS}	-	-	100	nA	V _{GS} =20V, V _{DS} =0V
Drain-source on-state resistance	R _{DS(on)}	-	0.052 0.115	0.060	Ω	V _{GS} =10V, I _D =15.9A, T _j =25°C V _{GS} =10V, I _D =15.9A, T _j =150°C
Gate resistance	R _G	-	0.8	-	Ω	f=1MHz, open drain

Table 5 **Dynamic characteristics**

Dovementor	Comple ed	Values			I I m i 4	Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	Ciss	-	2850	-	pF	V _{GS} =0V, V _{DS} =400V, f=250kHz
Output capacitance	Coss	-	54	-	pF	V _{GS} =0V, V _{DS} =400V, f=250kHz
Effective output capacitance, energy related ¹⁾	C _{o(er)}	-	101	-	pF	V _{GS} =0V, V _{DS} =0400V
Effective output capacitance, time related ²⁾	C _{o(tr)}	-	1050	-	pF	I_D =constant, V_{GS} =0V, V_{DS} =0400V
Turn-on delay time	t _{d(on)}	-	15.5	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =15.9A, $R_{\rm G}$ =3.3 Ω ; see table 9
Rise time	t _r	-	11	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =15.9A, $R_{\rm G}$ =3.3 Ω ; see table 9
Turn-off delay time	$t_{ m d(off)}$	-	79	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =15.9A, $R_{\rm G}$ =3.3 Ω ; see table 9
Fall time	t _f	_	4	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =15.9A, $R_{\rm G}$ =3.3 Ω ; see table 9

Table 6 Gate charge characteristics

Parameter	Symbol	Values			11	Nata / Tast Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q _{gs}	-	14	-	nC	V_{DD} =400V, I_{D} =15.9A, V_{GS} =0 to 10V
Gate to drain charge	$Q_{ m gd}$	-	23	-	nC	V_{DD} =400V, I_{D} =15.9A, V_{GS} =0 to 10V
Gate charge total	Qg	-	68	_	nC	V_{DD} =400V, I_{D} =15.9A, V_{GS} =0 to 10V
Gate plateau voltage	V _{plateau}	-	5.0	-	V	V_{DD} =400V, I_{D} =15.9A, V_{GS} =0 to 10V

 $^{^{1)}}$ $C_{\text{o(er)}}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 400V $^{2)}$ $C_{\text{o(tr)}}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 400V





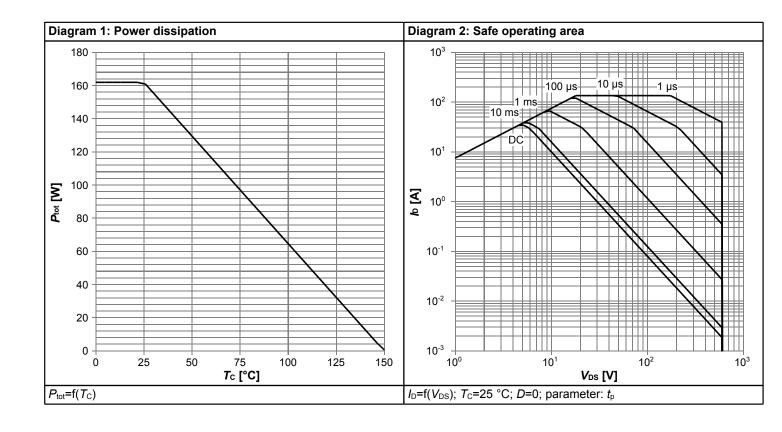
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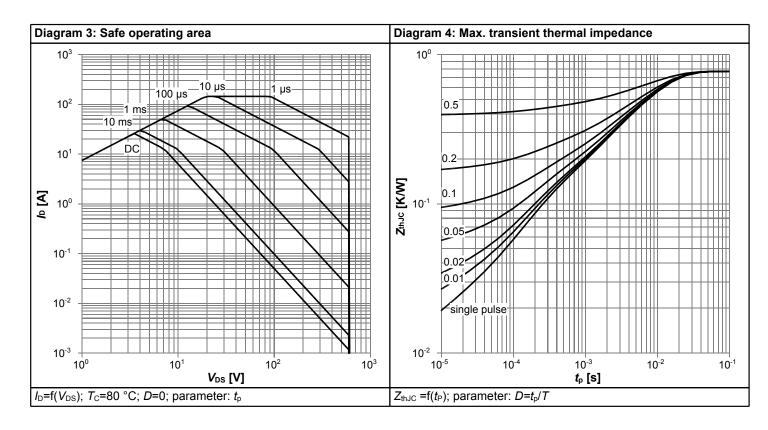
Table 7 Reverse diode characteristics

Parameter	Cymphal	Values			Unit	Nata / Tant Candition
	Symbol	Min.	Тур.	Max.	Ullit	Note / Test Condition
Diode forward voltage	V _{SD}	-	0.9	-	V	V _{GS} =0V, I _F =15.9A, T _j =25°C
Reverse recovery time	t _{rr}	-	390	_	ns	V_R =400V, I_F =15.9A, di_F/dt =100A/ μ s; see table 8
Reverse recovery charge	Q _{rr}	-	6	_	μC	V_R =400V, I_F =15.9A, di_F/dt =100A/ μ s; see table 8
Peak reverse recovery current	I _{rrm}	-	32	-	А	V_R =400V, I_F =15.9A, di_F/dt =100A/ μ s; see table 8

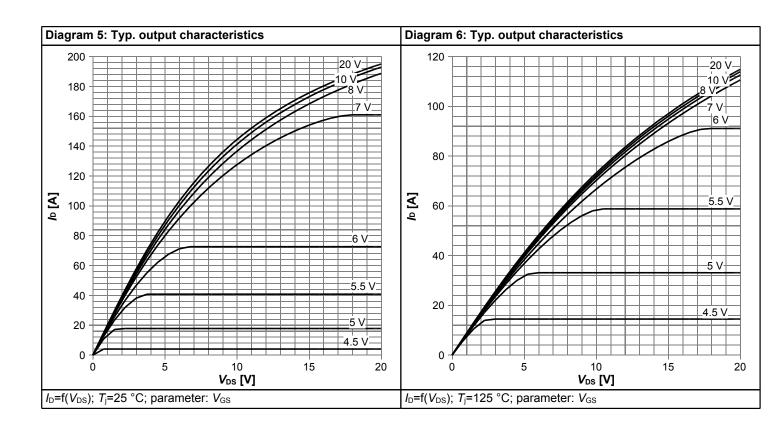


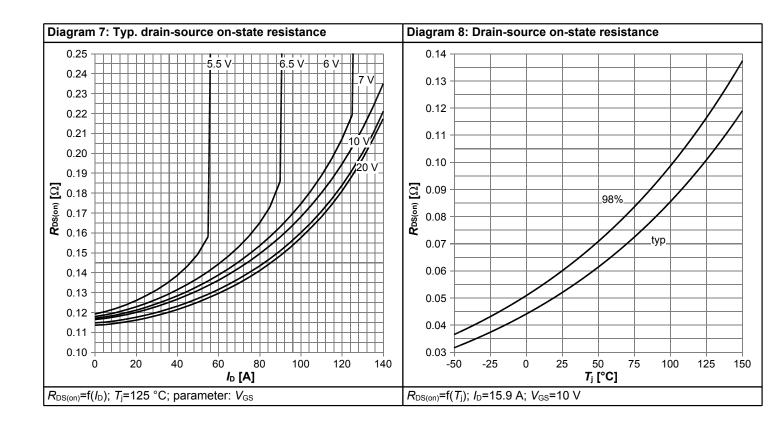
5 Electrical characteristics diagrams



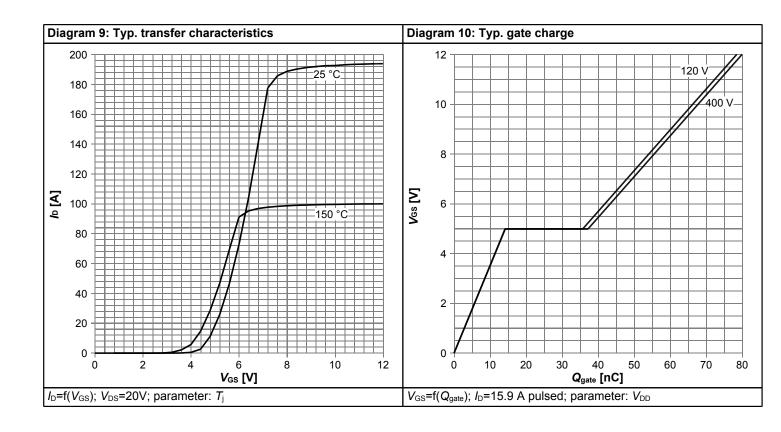


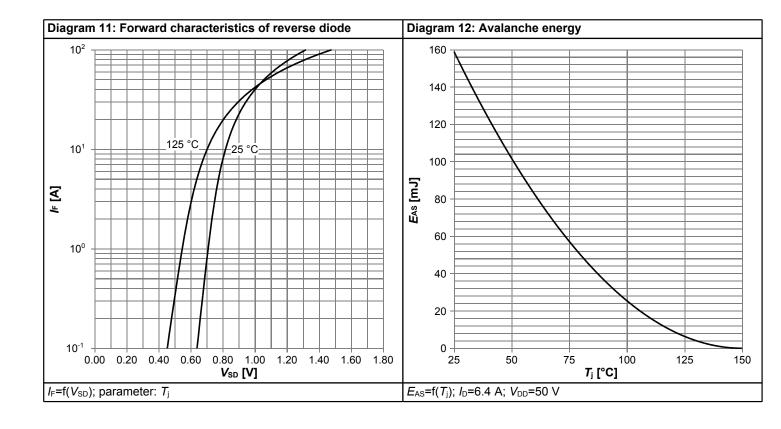




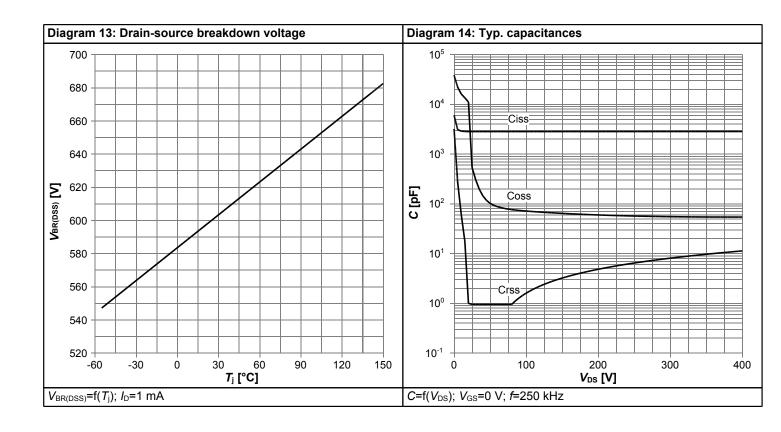


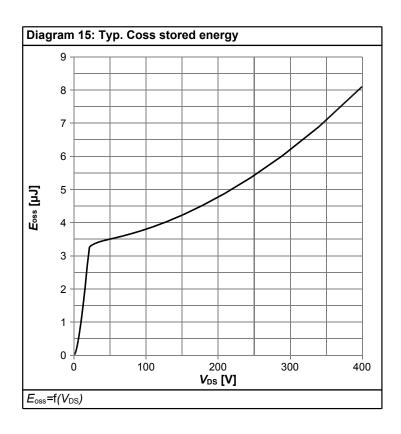














6 Test Circuits

Table 8 Diode characteristics

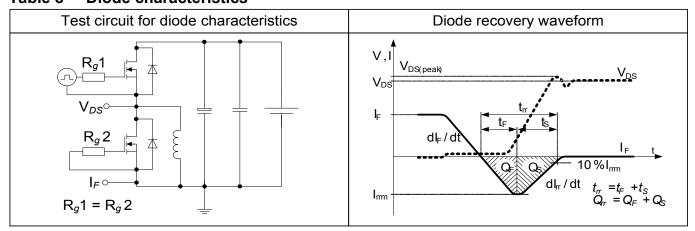


Table 9 Switching times

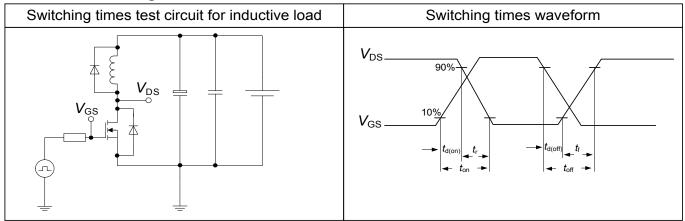
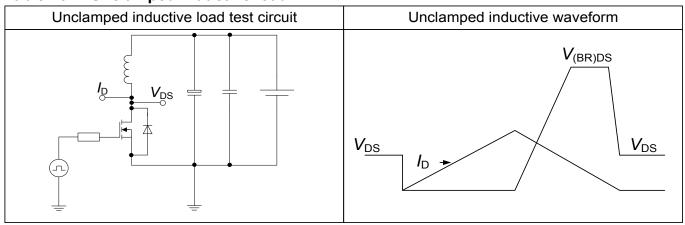


Table 10 Unclamped inductive load





7 Package Outlines

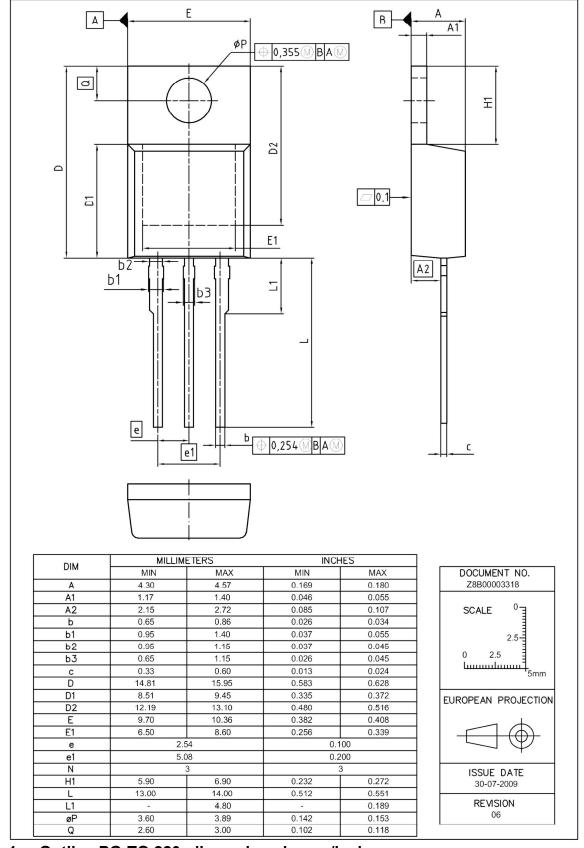


Figure 1 Outline PG-TO 220, dimensions in mm/inches



8 Appendix A

Table 11 Related Links

- IFX CoolMOS[™] C7 Webpage: <u>www.infineon.com</u>
- IFX CoolMOS[™] C7 application note: <u>www.infineon.com</u>
- IFX CoolMOS[™] C7 simulation model: www.infineon.com
- IFX Design tools: www.infineon.com



600V CoolMOS™ C7 Power Transistor

IPP60R060C7

Revision History

IPP60R060C7

Revision: 2015-11-30, Rev. 2.0

Previous Revision

1 To Toda Tevrolon						
Revision	Date	Subjects (major changes since last revision)				
2.0	2015-11-30	Release of final version				

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